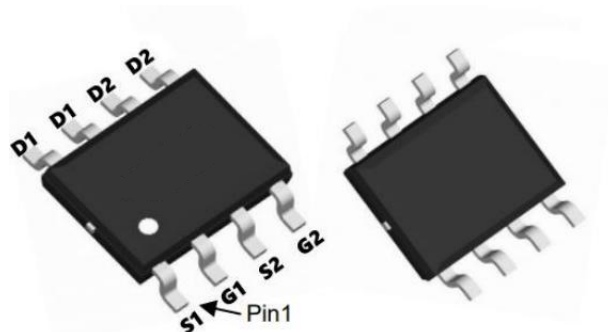
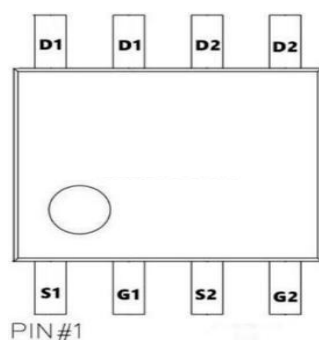


### Description

The SX5G10S uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.



### General Features

$V_{DS} = 100V$   $I_D = 8.8A$

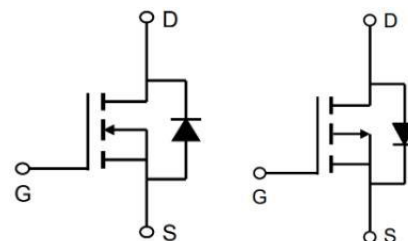
$R_{DS(ON)} < 120m\Omega$  @  $V_{GS} = 10V$

$V_{DS} = -100V$   $I_D = -4.8A$

$R_{DS(ON)} < 290m\Omega$  @  $V_{GS} = -10V$

### Application

BLDC



### Absolute Maximum Ratings ( $T_c = 25^\circ C$ unless otherwise noted)

Symbol	Parameter	N-Ch	P-Ch	Units
$V_{DS}$	Drain-Source Voltage	100	-100	V
$V_{GS}$	Gate-Source Voltage	$\pm 20$	$\pm 20$	V
$I_D @ T_c = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V^1$	8.8	4.8	A
$I_D @ T_c = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V^1$	5.9	-3.5	A
$I_{DM}$	Pulsed Drain Current <sup>2</sup>	28	-14.8	A
EAS	Single Pulse Avalanche Energy <sup>3</sup>	28	18	mJ
$P_D @ T_c = 25^\circ C$	Total Power Dissipation <sup>4</sup>	23	21.3	W
$T_{STG}$	Storage Temperature Range	-55 to 150		$^\circ C$
$T_J$	Operating Junction Temperature Range	-55 to 150		$^\circ C$
$R_{\theta JA}$	Thermal Resistance Junction-Ambient <sup>1</sup>	62.5		$^\circ C/W$
$R_{\theta JC}$	Thermal Resistance Junction-Case <sup>1</sup>	5.4		$^\circ C/W$

**N-Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)**

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Units
V(BR)DSS	Drain-Source Breakdown Voltage	VGS=0V, ID=250μA	100	113	-	V
IDSS	Zero Gate Voltage Drain Current	VDS=100V, VGS=0V,	-	-	1.0	μA
IGSS	Gate to Body Leakage Current	VDS=0V, VGS=±20V	-	-	±100	nA
VGS(th)	Gate Threshold Voltage	VDS=VGS, ID=250μA	1.2	2.0	2.5	V
RDS(on)	Static Drain-Source on-Resistance note3	VGS=10V, ID=5A	-	85	120	mΩ
		VGS=4.5V, ID=3A	-	95	150	mΩ
g fs	Forward Transconductance	V DS =5V , I D =5A		14		S
RG	Gate Resistance	VDS = 0V, VGS =0V,f =1MHz		3		Ω
Ciss	Input Capacitance	VDS=15V, VGS=0V, f=1.0MHz	-	1100	-	pF
Coss	Output Capacitance		-	55	-	pF
Crss	Reverse Transfer Capacitance		-	40	-	pF
Qg	Total Gate Charge	VDS=50V, ID=5A, VGS=10V	-	11.9	-	nC
Qgs	Gate-Source Charge		-	2.8	-	nC
Qgd	Gate-Drain("Miller") Charge		-	1.7	-	nC
td(on)	Turn-on Delay Time	VDS=30V, ID=5A, RG=1.8Ω, VGS=10V	-	3.8	-	ns
tr	Turn-on Rise Time		-	25.8	-	ns
td(off)	Turn-off Delay Time		-	16	-	ns
tf	Turn-off Fall Time		-	8.8	-	ns
IS	Continuous Source Current1,5	VG=VD=0V , Force Current	-	-	14.6	A
ISM	Pulsed Source Current2,5		-	-	25	A
VSD	Diode Forward Voltage2	VGS=0V, IS=10A	-	-	1.2	V

**Note :**

- 1、The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.
- 2、The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%
- 3、The power dissipation is limited by 150°C junction temperature
- 4、The data is theoretically the same as I D and I DM , in real applications , should be limited by total power dissipation.

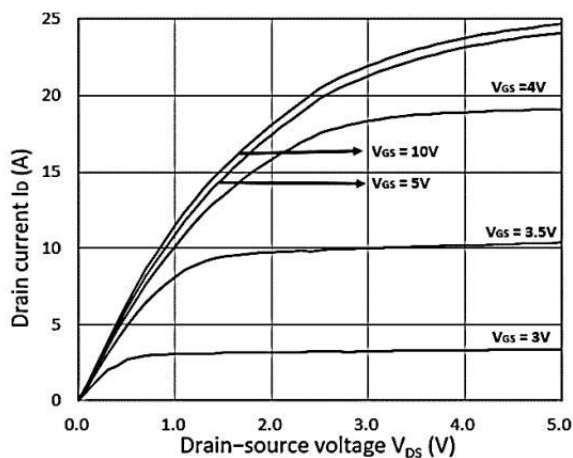
**P-Electrical Characteristics (T<sub>J</sub>=25°C, unless otherwise noted)**

Symbol	Parameter	Test Condition	Min.	Typ	Max.	Units
BVDSS	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0V, I <sub>D</sub> = -250μA	-100	117	-	V
IDSS	Zero Gate Voltage Drain Current	V <sub>DS</sub> = -100V, V <sub>GS</sub> = 0V	-	-	1	μA
IGSS	Gate to Body Leakage Current	V <sub>DS</sub> = 0V, V <sub>GS</sub> = ±20V	-	-	±100	nA
VGS(th)	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = -250μA	-1.2	-1.85	-2.5	V
RDS(on)	Static Drain-Source On-Resistance <sup>note1</sup>	V <sub>GS</sub> = -10V, I <sub>D</sub> = -5A	-	250	300	mΩ
		V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -3A	-	260	340	
Ciss	Input Capacitance	V <sub>DS</sub> = -50V, V <sub>GS</sub> = 0V, f = 1.0MHz	-	760	-	pF
Coss	Output Capacitance		-	25	-	pF
Crss	Reverse Transfer Capacitance		-	12	-	pF
Q <sub>g</sub>	Total Gate Charge	V <sub>DD</sub> = -50V, I <sub>D</sub> = -5A, V <sub>GS</sub> = -10V	-	11.5	-	nC
Q <sub>gs</sub>	Gate-Source Charge		-	1.3	-	nC
Q <sub>gd</sub>	Gate-Drain("Miller") Charge		-	2.9	-	nC
td(on)	Turn-On Delay Time	V <sub>DS</sub> = -50V, I <sub>D</sub> = -5A R <sub>G</sub> =4.5Ω, R <sub>L</sub> =25Ω V <sub>GEN</sub> = - 10 V	-	12	-	ns
t <sub>r</sub>	Turn-On Rise Time		-	5	-	ns
td(off)	Turn-Off Delay Time		-	35	-	ns
t <sub>f</sub>	Turn-Off Fall Time		-	20	-	ns
IS	Maximum Continuous Drain to Source Diode Forward Current		-	-	-12.8	A
VSD	Drain to Source Diode Forward Voltage	V <sub>GS</sub> = 0V, I <sub>S</sub> = -1A	-	-	-1.3	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0V, I <sub>sd</sub> = -3A, di/dt =100A/μs	-	25	-	nS
Q <sub>rr</sub>	Reverse Recovery Charge		-	20	-	nC

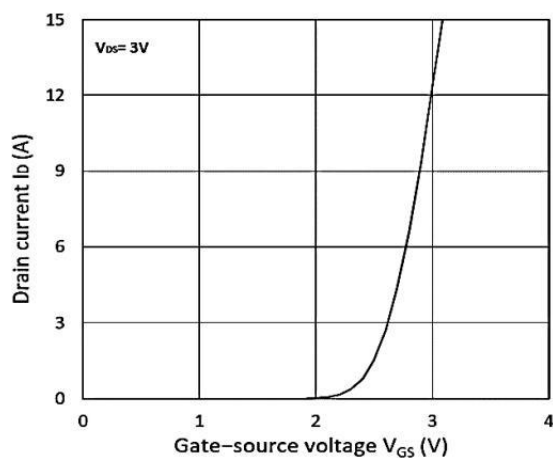
**Note :**

- 1、 The data tested by surface mounted on a 1 inch 2 FR-4 board with 20Z copper.
- 2、 The data tested by pulsed , pulse width .The EAS data shows Max. rating .
- 3、 The power dissipation is limited by 175°C junction temperature
- 4、 The data is theoretically the same as ID and IDM , in real applications , should be limited by total power dissipation.

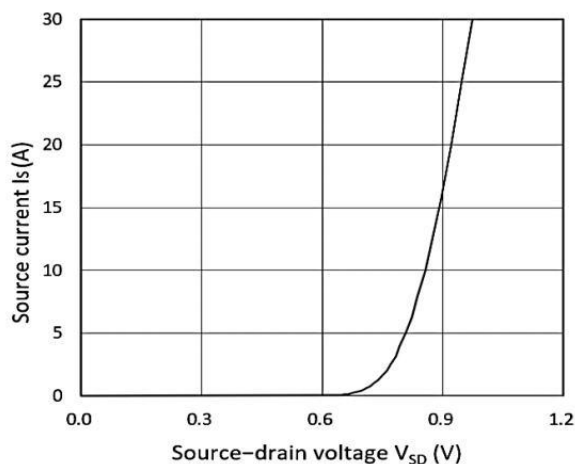
## N-Typical Characteristics



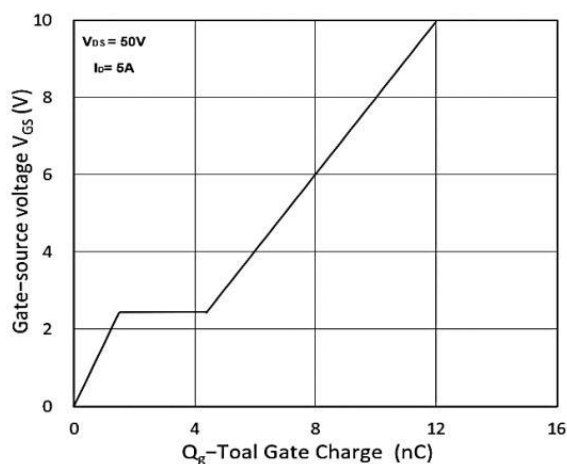
**Figure 1. Output Characteristics**



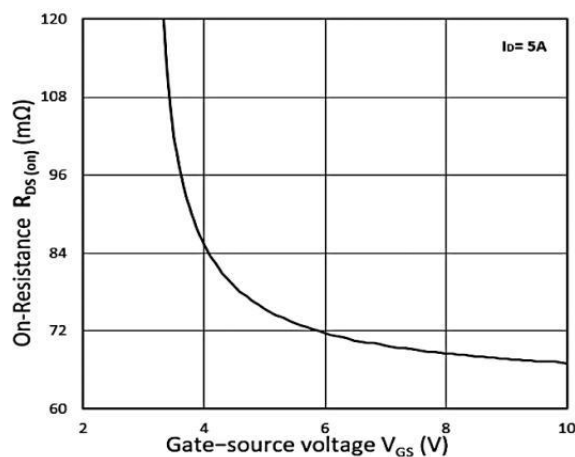
**Figure 2. Transfer Characteristics**



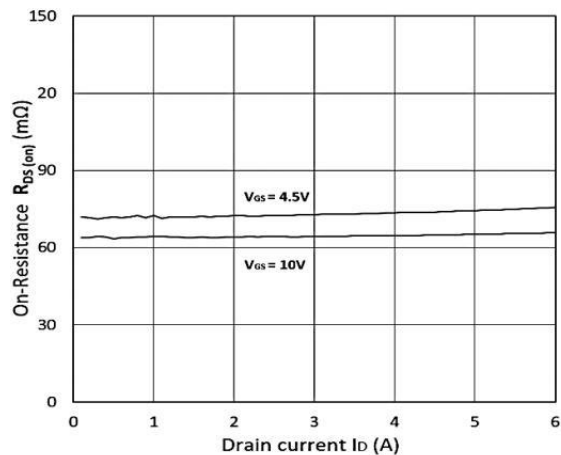
**Figure 3. Forward Characteristics of Reverse**



**Figure 4. Gate Charge Characteristics**



**Figure 5. R\_DS(on) vs. V\_GS**



**Figure 6. R\_DS(on) vs. I\_D**

## N-Typical Characteristics

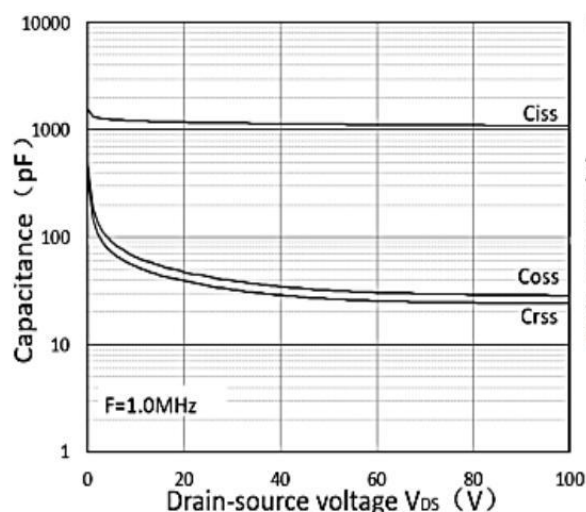


Figure 7. Capacitance Characteristics

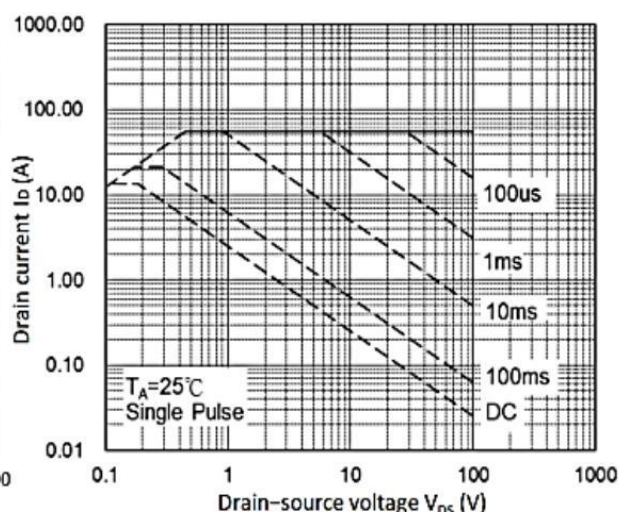


Figure 8. Safe Operating Area

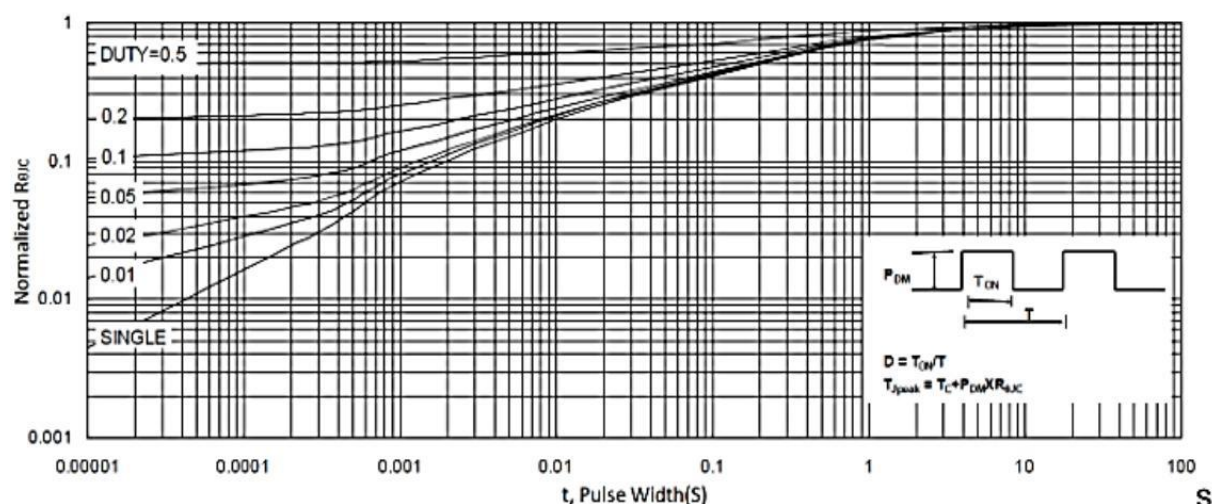


Figure 9. Normalized Maximum Transient Thermal Impedance

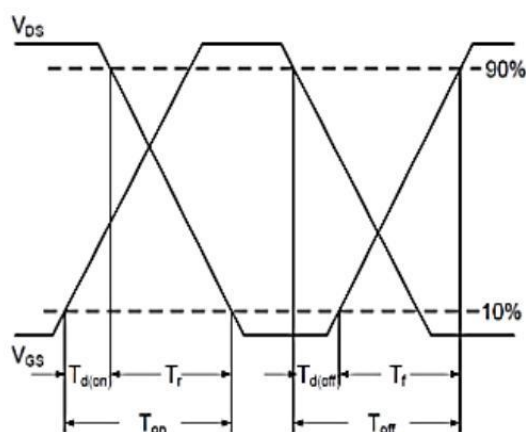


Figure 10. Switching Time Waveform

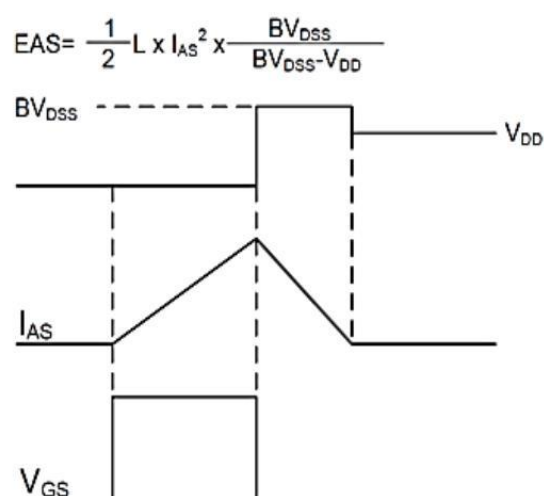


Figure 11. Unclamped Inductive Switching Waveform

## P-Typical Characteristics

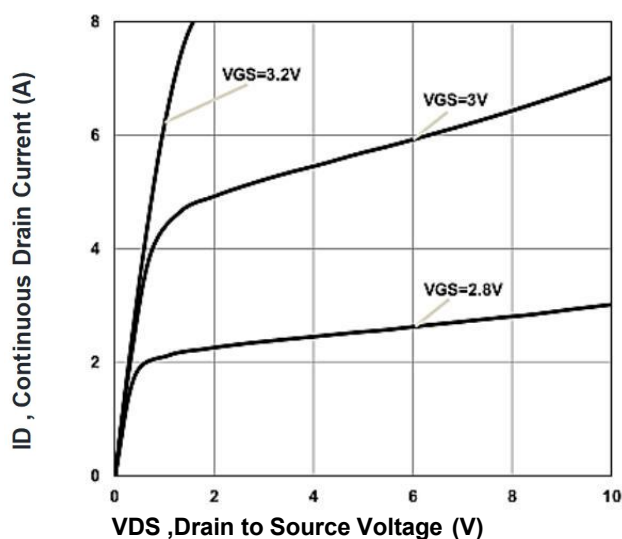


Figure 1. Typical Output Characteristics

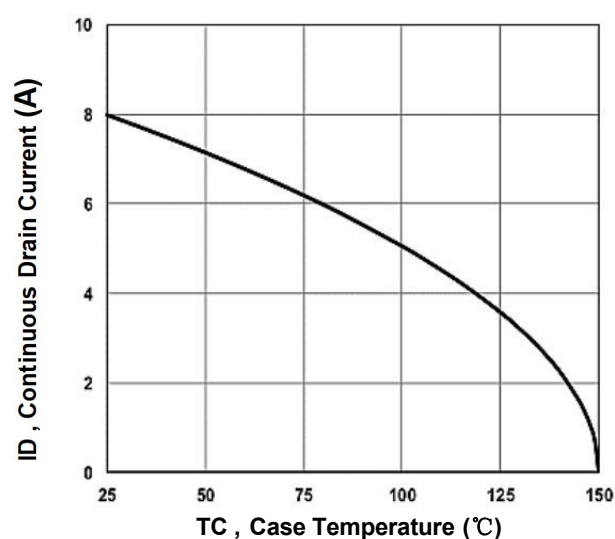


Figure 2. Continuous Drain Current vs.  $T_C$

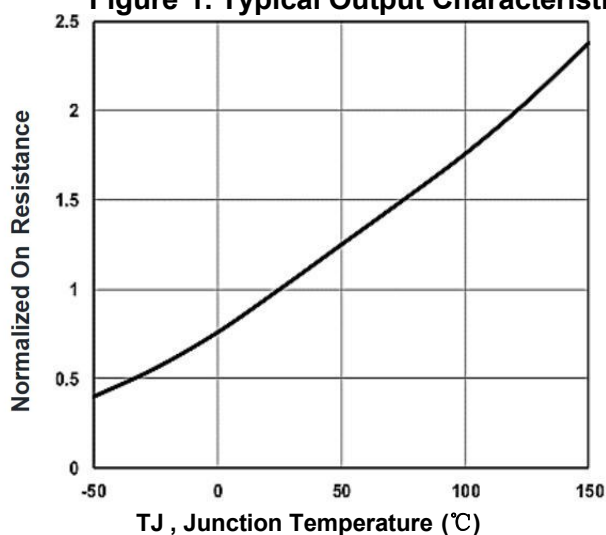


Figure 3. Normalized  $R_{DS(on)}$  vs.  $T_J$

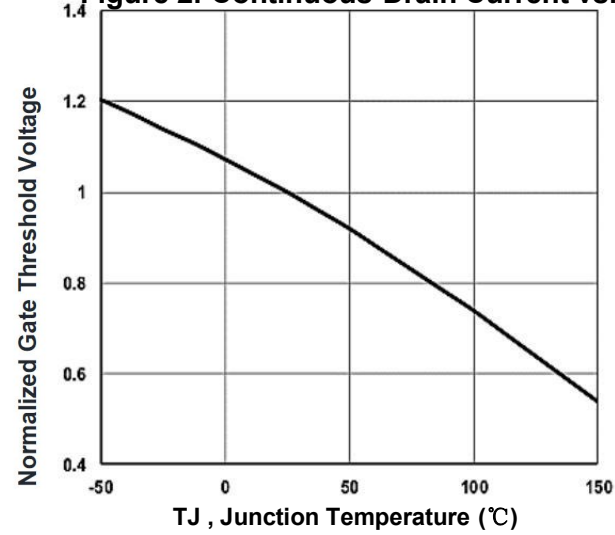


Figure 5. Normalized  $V_{th}$  vs.  $T_J$

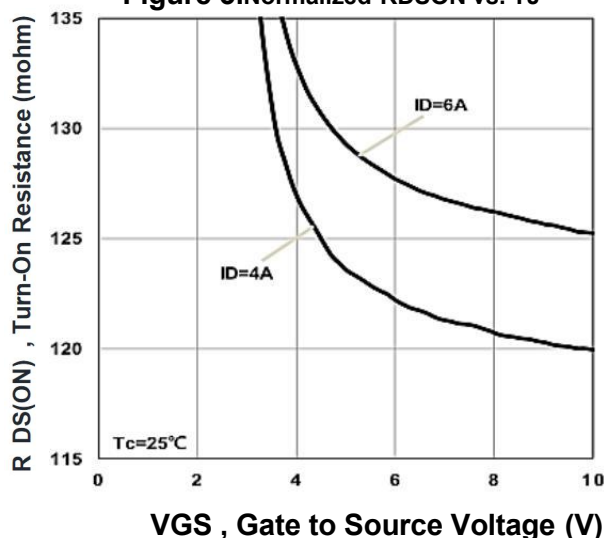


Figure 6. Turn-On Resistance vs.  $V_{GS}$

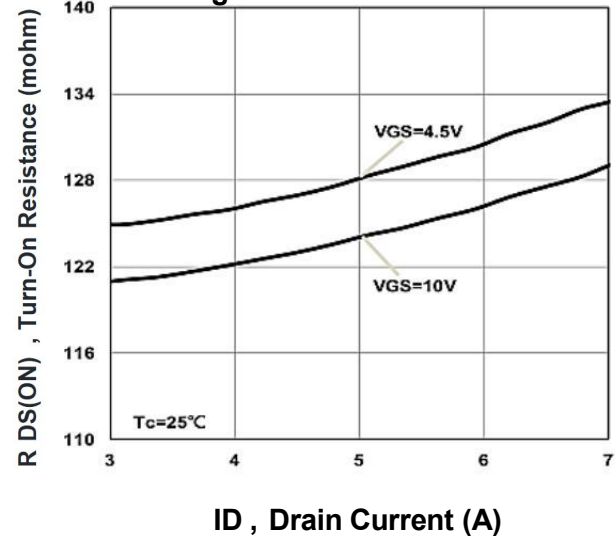
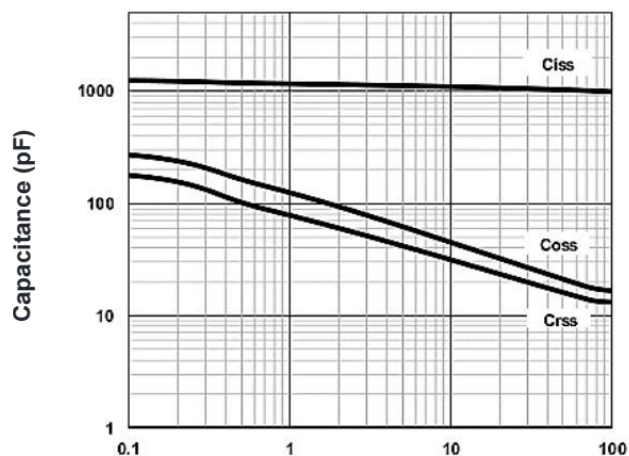
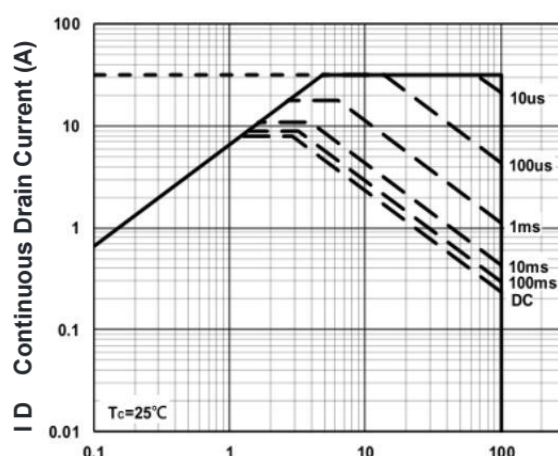


Figure 7. Turn-On Resistance vs.  $I_D$

## P-Typical Characteristics



VDS , Drain to Source Voltage (V)  
Figure 8. Capacitance Characteristics



VDS , Drain to Source Voltage (V)  
Figure 9. Maximum Safe Operation Area

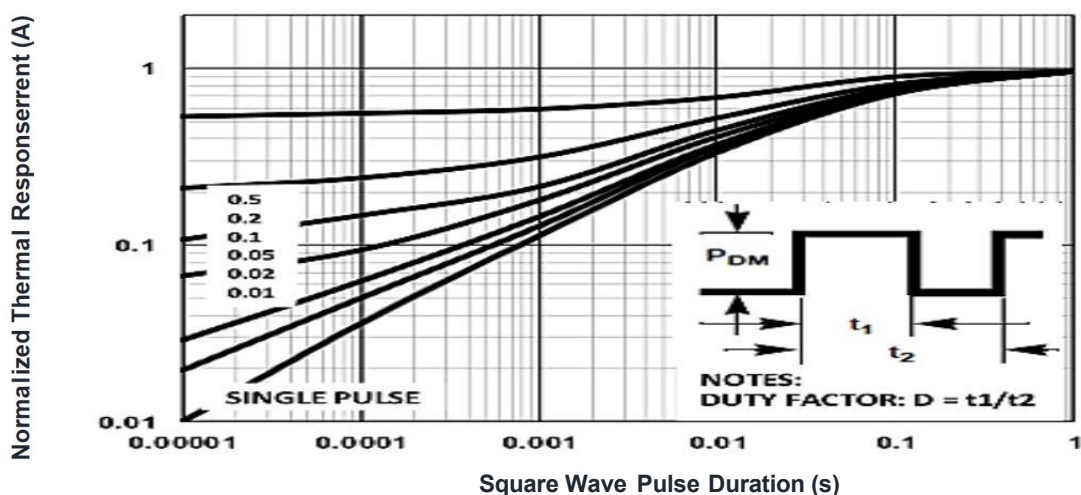


Figure 10. Normalized Transient Impedance

$$EAS = \frac{1}{2} L \times I_{AS}^2 \times \frac{BV_{DSS}}{BV_{DSS} - V_{DD}}$$

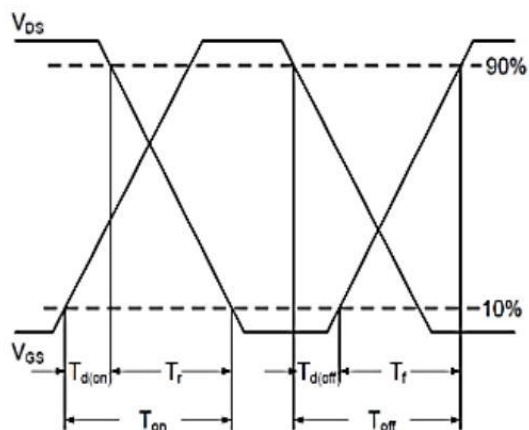


Figure 10. Switching Time Waveform

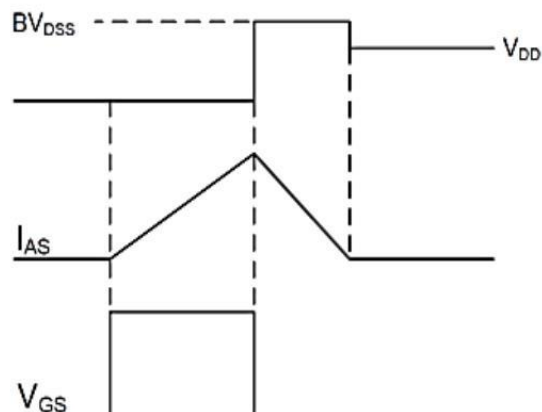
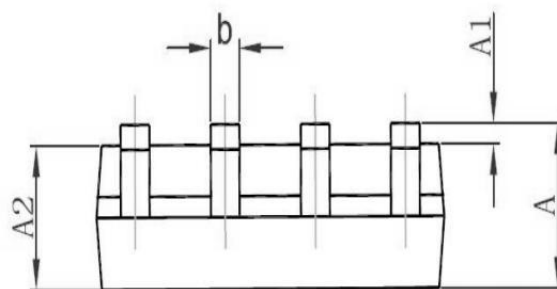
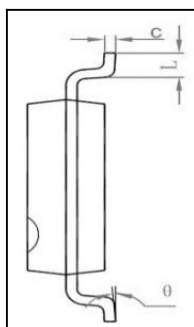
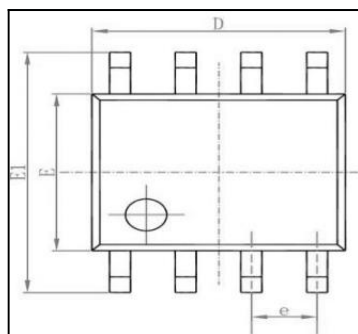
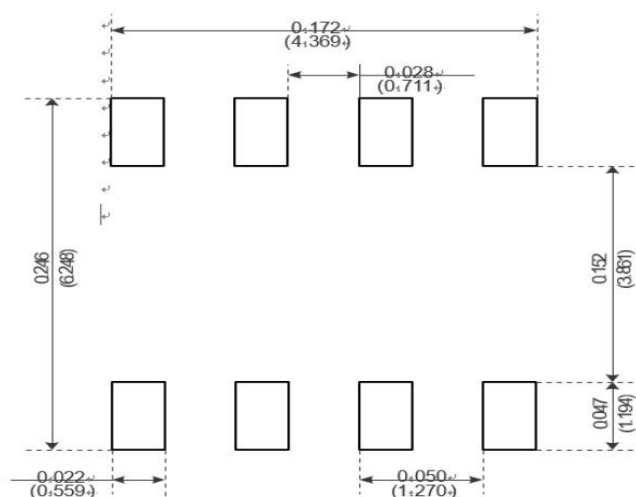


Figure 11. Unclamped Inductive Switching Waveform

## Package Mechanical Data-SOP-8



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270 (BSC)		0.050 (BSC)	
L	0.400	1.270	0.016	0.050
θ	0°	8°	0°	8°



Recommended Minimum Pads

## Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
TAPING	SOP-8		3000